

Tentative

CM600DY-12NF

Pre.	S.Uchida	Rev	B	H. Hanada.
Apr.	M.Tabata 13-Sep.-'02			M.Tabata 21-Feb.-'03

HIGH POWER SWITCHING USE

Notice : This is not a final specification. Some parametric limits are subject to change.

CM600DY-12NF

- I_c 600A
- V_{CES} 600V
- Insulated Type
- 2-elements in a pack

APPLICATION

General purpose inverters & Servo controls,etc

ABSOLUTE MAXIMUM RATINGS ($T_j = 25^\circ\text{C}$)

Symbol	Item	Conditions	Ratings	Units
V_{CES}	Collector-emitter voltage	G-E Short	600	V
V_{GES}	Gate-emitter voltage	C-E Short	± 20	V
I_c	Collector current	DC, $T_c = 89^\circ\text{C}$ * ³	600	A
		Pulse (2)	1200	
I_E (1)	Emitter current		600	A
		Pulse (2)	1200	
I_{EM} (1)				B
P_c (3)	Maximum collector dissipation	$T_c = 25^\circ\text{C}$	1130	W
T_j	Junction temperature		-40~+150	°C
T_{stg}	Storage temperature		-40~+125	°C
V_{iso}	Isolation voltage	Main terminal to base plate, AC 1 min.	2500	V
—	Torque strength	Main terminal M6	3.5 ~ 4.5	N·m
—	Torque strength	Mounting holes M6	3.5 ~ 4.5	N·m
—	Weight	Typical value	580	g

APPLICATION NOTE

MITSUBISHI<IGBT MODULE>

CM600DY-12NF
HIGH POWER SWITCHING USE

ELECTRICAL CHARACTERISTICS ($T_j = 25^\circ\text{C}$)

Symbol	Item	Conditions	Min.	Typ.	Max.	Units
I_{CES}	Collector cutoff current	$V_{CE}=V_{GES}, V_{GE}=0\text{V}$	—	—	1	mA
$V_{GE(h)}$	Gate-emitter threshold voltage	$I_c=60\text{mA}, V_{CE}=10\text{V}$	5	6	7.5	V
I_{GES}	Gate leakage current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}$	—	—	0.5	μA
$V_{CE(\text{sat})}$	Collector to emitter saturation voltage	$T_j = 25^\circ\text{C}$	$I_c = 600\text{A}$	—	1.7	2.2
		$T_j = 125^\circ\text{C}$	$V_{GE}=15\text{V}$	—	1.7	—
C_{IES}	Input capacitance	$V_{CE}=10\text{V}$	—	—	90	nF
C_{OES}	Output capacitance	$V_{GE}=0\text{V}$	—	—	11	
C_{RES}	Reverse transfer capacitance	—	—	—	3.6	
Q_g	Total gate charge	$V_{CC}=300\text{V}, I_c=600\text{A}, V_{GE}=15\text{V}$	—	2400	—	nC
$t_{d(on)}$	Turn-on delay time	$V_{CC}=300\text{V}, I_c=600\text{A}$	—	—	500	ns
t_r	Turn-on rise time	$V_{GE1}=V_{GE2}=15\text{V}$	—	—	300	
$t_{d(off)}$	Turn-off delay time	$R_G = 4.2\Omega$, Inductive load switching operation	—	—	750	
t_f	Turn-off fall time	—	—	—	300	
$t_{rr} \text{ (1)}$	Reverse recovery time	$I_E=600\text{A}$	—	—	250	ns
$Q_{rr} \text{ (1)}$	Reverse recovery charge	—	—	8.7	—	μC
$V_{EC} \text{ (1)}$	Emitter-collector voltage	$I_E=600\text{A}, V_{GE}=0\text{V}$	—	—	2.6	V
$R_{th(j-c)Q}$	Thermal resistance	IGBT part (1/2 module) *1	—	—	0.11	$^\circ\text{C}/\text{W}$
$R_{th(j-c)R}$		FWDi part(1/2 module) *1	—	—	0.18	
$R_{th(c-f)}$	Contact thermal resistance	Case to fin, Thermal compound Applied (1/2module) *2	—	0.02	—	
$R_{th(j-c')Q}$	Thermal resistance	IGBT part (1/2 module) *3	—	—	0.046	
R_G	External gate resistance	—	1.0	—	10	Ω

*1: T_c measured point is shown in page OUTLINE DRAWING.

*2: Typical value is measured by using Shin-etsu Silicone "G-746".

*3: T_c' measured point is just under the chips.

If you use this value, $R_{th(f-a)}$ should be measured just under the chips..

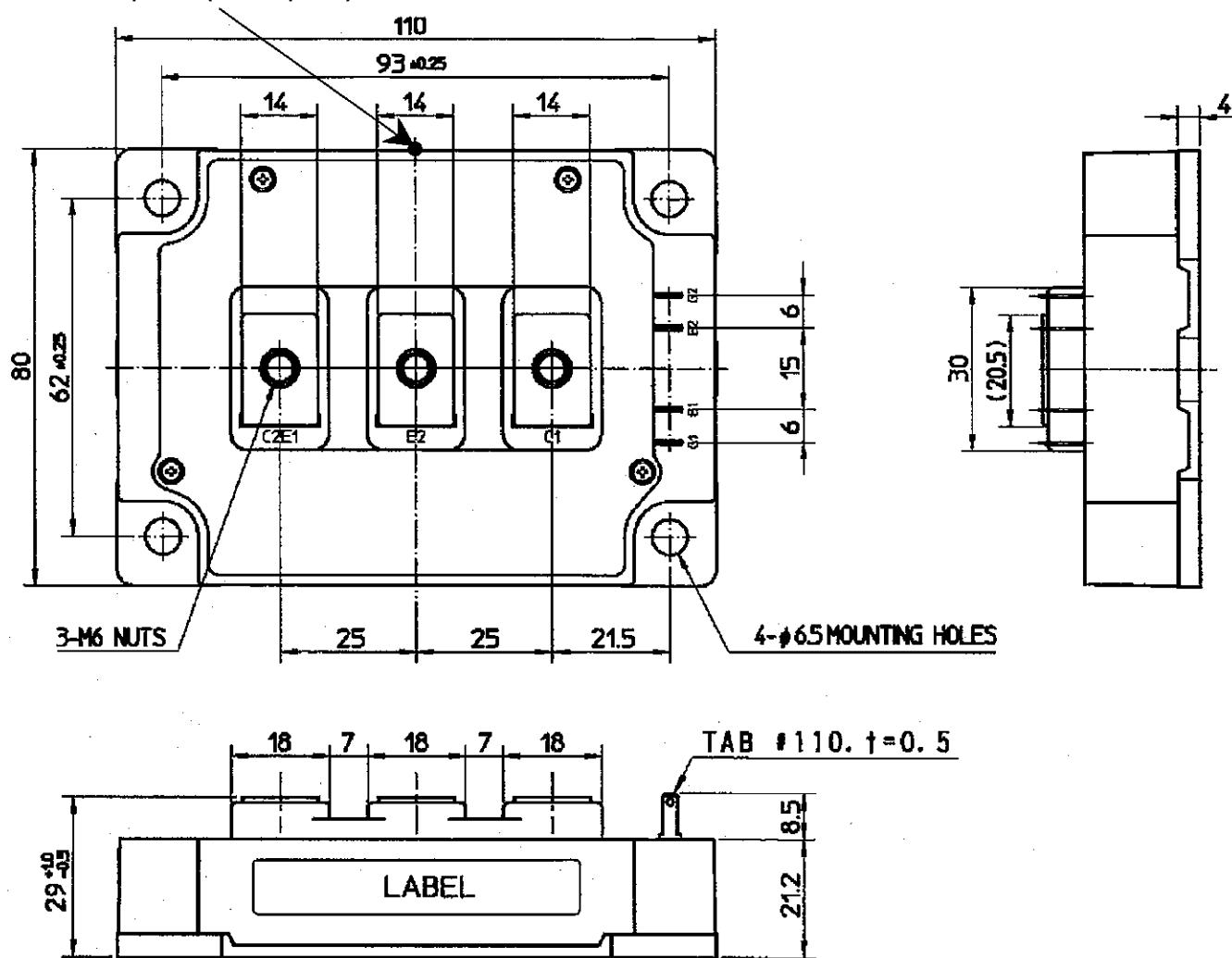
- ① $I_E, V_{EC}, t_{rr}, Q_{rr}$ & die/dt represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWDi).
- ② Pulse width and repetition rate should be such that the device junction temp. (T_j) dose not exceed T_{jmax} rating.
- ③ Junction temperature (T_j) should not increase beyond 150°C .
- ④ Pulse width and repetition rate should be such as to cause neglible temperature rise.

OUTLINE DRAWING

Dimensions in mm

A

Tc measured point (Base plate)



CIRCUIT DIAGRAM

